## General Description

The MAX4238/MAX4239 are low-noise, low-drift, ultra-high precision amplifiers that offer near-zero DC offset and drift through the use of patented autocorrelating zeroing techniques. This method constantly measures and compensates the input offset, eliminating drift over time and temperature and the effect of 1/f noise. Both devices feature rail-to-rail outputs, operate from a single 2.7V to 5.5V supply, and consume only 600µA. An active-low shutdown mode decreases supply current to 0.1µA.

The MAX4238 is unity-gain stable with a gain-bandwidth product of 1MHz, while the decompensated MAX4239 is stable with $A_V \geq 10V/V$ and a GBWP of 6.5MHz. The MAX4238/MAX4239 are available in 8-pin narrow SO, 6-pin TDFN and SOT23 packages.

Applications

- Thermocouples
- Strain Gauges
- Electronic Scales
- Medical Instrumentation
- Instrumentation Amplifiers

Typical Application Circuit
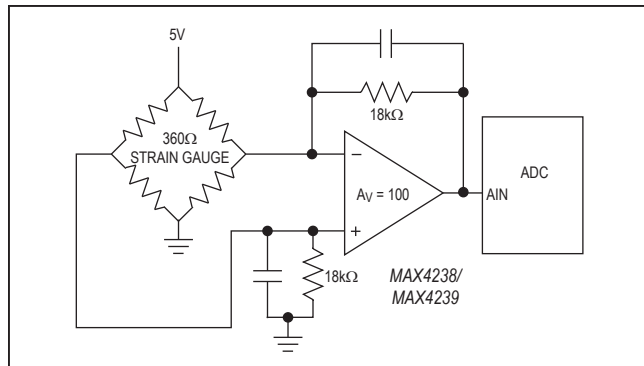
Pin Configurations appear at end of data sheet.

Benefits and Features

- DC Performance Ideal for High-Precision Sensor Interface
  - Ultra-Low, 0.1µV Offset Voltage
    - 2.0µV (max) at +25°C
    - 2.5µV (max) at -40°C to +85°C
    - 3.5µV (max) at -40°C to +125°C
  - Low 10nV/°C Drift
  - Low Noise: $1.5µV_{P-P}$ from DC to 10Hz
  - 150dB A_{VOL}, 140dB PSRR, 140dB CMRR
  - High Gain-Bandwidth Product
    - 1MHz (MAX4238)
    - 6.5MHz (MAX4239)
  - Ground-Sensing Input
  - Rail-to-Rail Output (R_L = 1kΩ)
- Low Power Consumption Reduces System Power
  - Single 2.7V to 5.5V Supply Voltage Range
  - 600µA Supply Current
  - 0.1µA Shutdown Mode

Ordering Information

PART	PIN-PACKAGE	TOP MARK
MAX4238AUT-T	6 SOT23	AAZZ
MAX4238AUT/V+T	6 SOT23	—
MAX4238ASA	8 SO	—
MAX4238ATT+T	6 TDFN-EP*	+ANG
MAX4239AUT-T	6 SOT23	ABAA
MAX4239AUT/V+T	6 SOT23	—
MAX4239ASA	8 SO	—
MAX4239ATT+T	6 TDFN-EP*	+ANH

Note: All devices are specified over the -40°C to +125°C operating temperature range.
+Denotes a lead(Pb)-free/RoHS-compliant package.
*EP = Exposed paddle.
/V denotes an automotive-qualified part.

Selector Guide

PART	MINIMUM STABLE GAIN	GAIN BANDWIDTH (MHz)
MAX4238	1V/V	1
MAX4239	10V/V	6.5

Absolute Maximum Ratings

Power-Supply Voltage (V_{CC} to GND)....................................6V
All Other Pins ....(V_{GND} - 0.3V) to (V_{CC} + 0.3V)
Output Short-Circuit Duration
  (OUT shorted to V_{CC} or GND) ....Continuous
Continuous Power Dissipation (T_A = +70°C)
  6-Pin Plastic SOT23
  (derate 9.1mW/°C above +70°C) 727mW
  8-Pin Plastic SO (derate 5.88mW/°C above +70°C)...471mW
  6-Pin TDFN-EP (derate 18.2mW above +70°C) 1454mW

Operating Temperature Range........................ -40°C to +125°C
Junction Temperature..+150°C
Storage Temperature Range........................... -65°C to +150°C
Lead Temperature (soldering, 10s) ....+300°C
Soldering Temperature (reflow)
  Lead(Pb)-Free Packages ....+260°C
  Packages Containing Lead..+240°C

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Electrical Characteristics

(2.7V ≤ V_{CC} ≤ 5.5V, V_{CM} = V_{GND} = 0V, V_{OUT} = V_{CC}/2, R_L = 10kΩ connected to V_{CC}/2, $\overline{SHDN}$ = V_{CC}, **T_A = +25°C**, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS
Input Offset Voltage	V_{OS}	(Note 1)			0.1	2	µV
Long-Term Offset Drift					50		nV/1000hr
Input Bias Current	I_B	(Note 2)			1		pA
Input Offset Current	I_{OS}	(Note 2)			2		pA
Peak-to-Peak Input Noise Voltage	en_{P-P}	RS = 100Ω, 0.01Hz to 10Hz			1.5		µVP-P
Input Voltage-Noise Density	e_n	f = 1kHz			30		NV/√Hz
Common-Mode Input Voltage Range	V_{CM}	Inferred from CMRR test		V_{GND} - 0.1		V_{CC} - 1.3	V
Common-Mode Rejection Ratio	CMRR	-0.1V ≤ V_{CM} ≤ V_{CC} - 1.3V (Note 1)		120	140		dB
Power-Supply Rejection Ratio	PSRR	2.7V ≤ V_{CC} ≤ 5.5V (Note 1)		120	140		dB
Large-Signal Voltage Gain	Av_{OL}	0.05V ≤ V_{OUT} ≤ V_{CC} - 0.05V (Note 1)	R_L = 10kΩ	125	150		dB
		0.1V ≤ V_{OUT} ≤ V_{CC} - 0.1V (Note 1)	R_L = 1kΩ	125	145		
Output Voltage Swing	V_{OH}/V_{OL}	R_L = 10kΩ	V_{CC} - V_{OH}		4	10	mV
			V_{OL}		4	10	
		R_L = 1kΩ	V_{CC} - V_{OH}		35	50	
			V_{OL}		35	50	
Output Short-Circuit Current		To either supply			40		mA
Output Leakage Current		0 ≤ V_{OUT} ≤ V_{CC}, SHDN = GND (Note 2)			0.01	1	µA
Slew Rate		V_{CC} = 5V, C_L = 100pF, V_{OUT} = 2V step	MAX4238		0.35		V/µs
			MAX4239		1.6		
Gain-Bandwidth Product	GBWP	R_L = 10kΩ, C_L = 100pF, measured at f = 100kHz	MAX4238		1		MHz
			MAX4239		6.5		
Minimum Stable Closed-Loop Gain		R_L = 10kΩ, C_L = 100pF, phase margin = 60°	MAX4238		1		V/V
			MAX4239		10		

Electrical Characteristics (continued)

(2.7V ≤ V_{CC} ≤ 5.5V, V_{CM} = V_{GND} = 0V, V_{OUT} = V_{CC}/2, R_L = 10kΩ connected to V_{CC}/2, $\overline{SHDN}$ = V_{CC}, **T_A = +25°C**, unless otherwise noted.)

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS
Maximum Closed-Loop Gain		R_L = 10kΩ, C_L = 100pF, phase margin = 60°	MAX4238		1000		V/V
			MAX4239		6700		
Settling Time		-1V step	0.1% (10 bit)		0.5		ms
			0.025% (12 bit)		1.0		
			0.006% (14 bit)		1.7		
			0.0015% (16 bit)		2.3		
Overload Recovery Time		AV = 10 (Note 4)	0.1% (10 bit)		3.3		ms
			0.025% (12 bit)		4.1		
			0.006% (14 bit)		4.9		
			0.0015% (16 bit)		5.7		
Startup Time		AV = 10	0.1% (10 bit)		1.8		ms
			0.025% (12 bit)		2.6		
			0.006% (14 bit)		3.4		
			0.0015% (16 bit)		4.3		
Supply Voltage Range	VCC	Inferred by PSRR test		2.7		5.5	V
Supply Current	ICC	SHDN = V_{CC}, no load, V_{CC} = 5.5V			600	850	µA
		SHDN = GND, V_{CC} = 5.5V			0.1	1	
Shutdown Logic-High	VIH			2.2			V
Shutdown Logic-Low	VIL					0.8	V
Shutdown Input Current		0V ≤ V_{SHDN} ≤ V_{CC}			0.1	1	µA

Electrical Characteristics

(2.7V ≤ V_{CC} ≤ 5.5V, V_{CM} = GND = 0V, V_{OUT} = V_{CC}/2, R_L = 10kΩ connected to V_{CC}/2, $\overline{SHDN}$ = V_{CC}, **T_A = -40°C to +125°C**, unless otherwise noted.) (Note 5)

PARAMETER	SYMBOL	CONDITIONS		MIN	TYP	MAX	UNITS
Input Offset Voltage	V_{OS}	(Note 1)	T_A = -40°C to +85°C			2.5	µV
			T_A = -40°C to +125°C			3.5	
Input Offset Drift	TCV_{OS}	(Note 1)			10		nV/°C
Common-Mode Input Voltage Range	V_{CM}	Inferred from CMRR test		V_{GND} - 0.05		V_{CC} - 1.4	V
Common-Mode Rejection Ratio	CMRR	V_{GND} - 0.05V ≤ V_{CM} ≤ V_{CC} – 1.4V (Note 1)	T_A = -40°C to +85°C	115			dB
			T_A = -40°C to +125°C	90			
Power-Supply Rejection Ratio	PSRR	2.7V ≤ V_{CC} ≤ 5.5V (Note 1)		120			dB
Large-Signal Voltage Gain	A_{VOL}	R_L = 10kΩ, 0.1V ≤ V_{OUT} ≤ V_{CC} - 0.1V (Note 1)	T_A = -40°C to +85°C	125			dB
			T_A = -40°C to +125°C	95			
		R_L = 1kΩ (Note 1)	0.1V ≤ V_{OUT} ≤ V_{CC} - 0.1V, T_A = -40°C to +85°C	120			dB
			0.2V ≤ V_{OUT} ≤ V_{CC} - 0.2V, T_A = -40°C to +125°C	80			
Output Voltage Swing	V_{OH}/V_{OL}	R_L = 10kΩ	V_{CC} - V_{OH}			20	mV
			V_{OL}			20	
		R_L = 1kΩ	V_{CC} - V_{OH}			100	
			V_{OL}			100	
Output Leakage Current		0V ≤ V_{OUT} ≤ V_{CC}, $\overline{SHDN}$ = GND (Note 3)				2	µA
Supply Voltage Range	V_{CC}	Inferred by PSRR test		2.7		5.5	V
Supply Current	I_{CC}	$\overline{SHDN}$ = V_{CC}, no load, V_{CC} = 5.5V				900	µA
		$\overline{SHDN}$ = GND, V_{CC} = 5.5V				2	
Shutdown Logic High	V_{IH}			2.2			V
Shutdown Logic Low	V_{IL}					0.7	V
Shutdown Input Current		0V ≤ $V_{\overline{SHDN}}$ ≤ V_{CC}				2	µA

Note 1: Guaranteed by design. Thermocouple and leakage effects preclude measurement of this parameter during production testing. Devices are screened during production testing to eliminate defective units.

Note 2: IN+ and IN- are gates to CMOS transistors with typical input bias current of 1pA. CMOS leakage is so small that it is impractical to test and guarantee in production. Devices are screened during production testing to eliminate defective units.
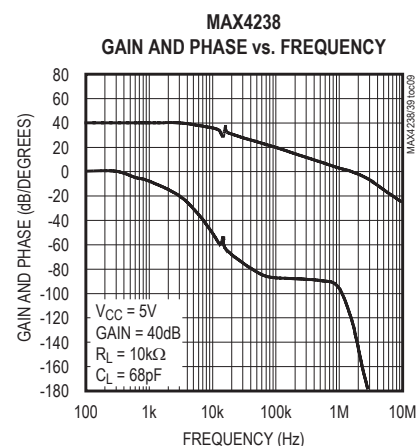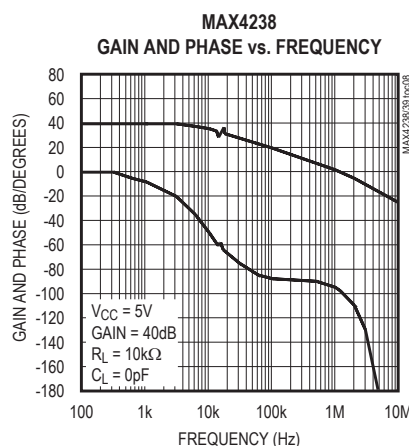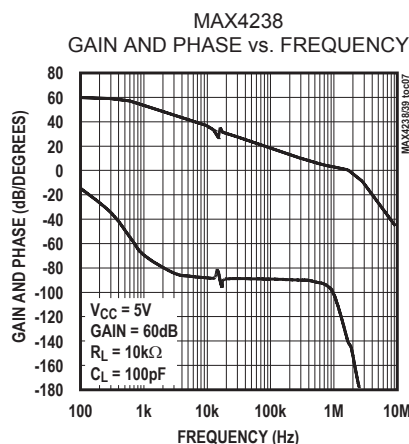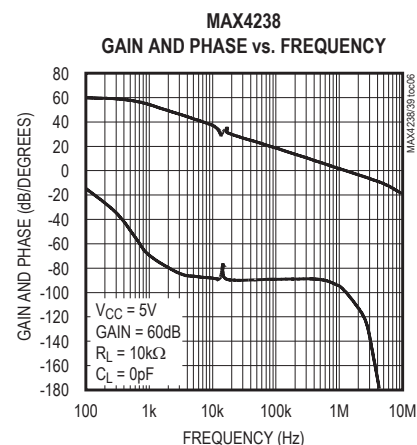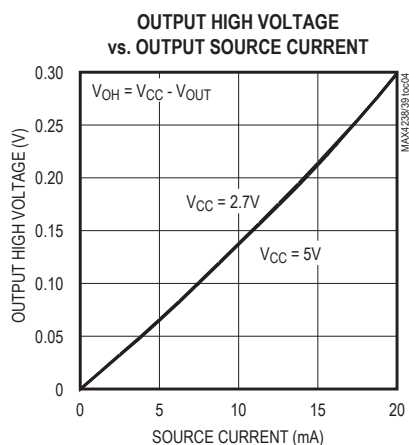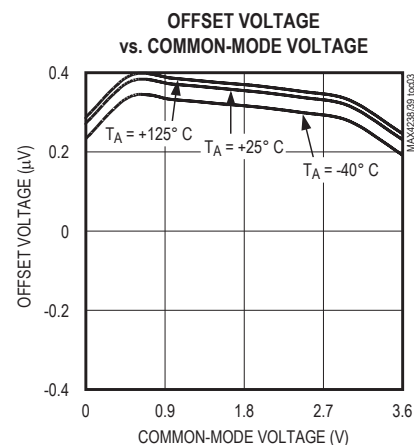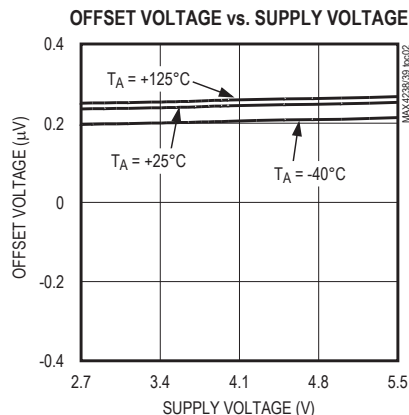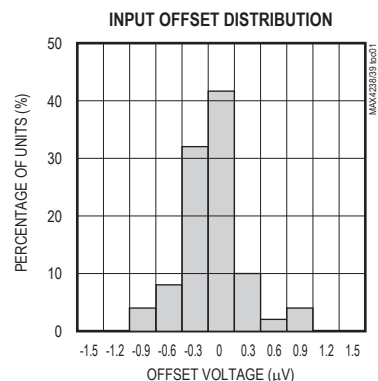
Note 3: Leakage does not include leakage through feedback resistors.

Note 4: Overload recovery time is the time required for the device to recover from saturation when the output has been driven to either rail.

Note 5: Specifications are 100% tested at T_A = +25°C, unless otherwise noted. Limits over temperature are guaranteed by design.
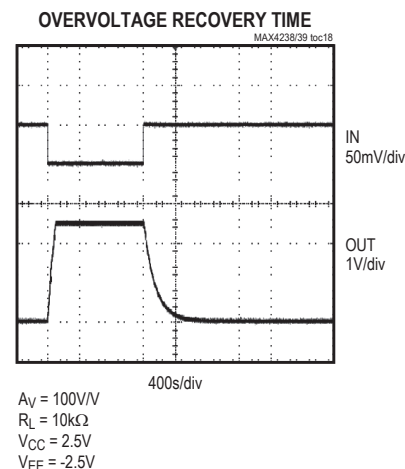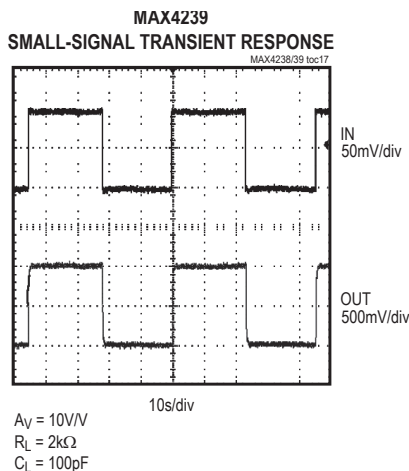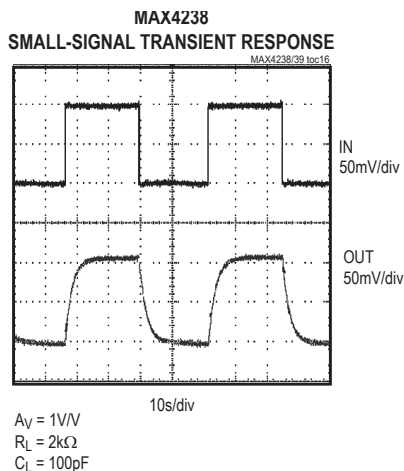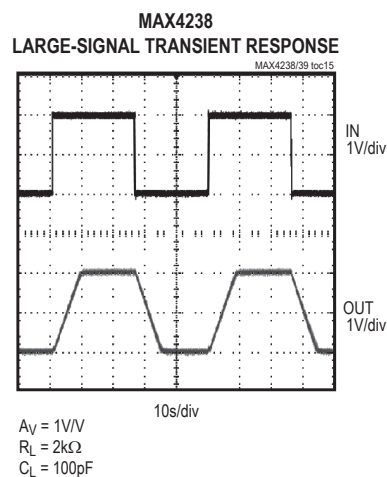
Typical Operating Characteristics

(V_{CC} = 5V, V_{CM} = 0V, R_L = 10kΩ connected to V_{CC}/2, $\overline{SHDN}$ = V_{CC}, T_A = +25°C, unless otherwise noted.)

INPUT OFFSET DISTRIBUTION

OFFSET VOLTAGE vs. SUPPLY VOLTAGE

OFFSET VOLTAGE vs. COMMON-MODE VOLTAGE

OUTPUT HIGH VOLTAGE vs. OUTPUT SOURCE CURRENT

OUTPUT LOW VOLTAGE vs. OUTPUT SINK CURRENT

MAX4238 GAIN AND PHASE vs. FREQUENCY

MAX4238 GAIN AND PHASE vs. FREQUENCY

MAX4238 GAIN AND PHASE vs. FREQUENCY

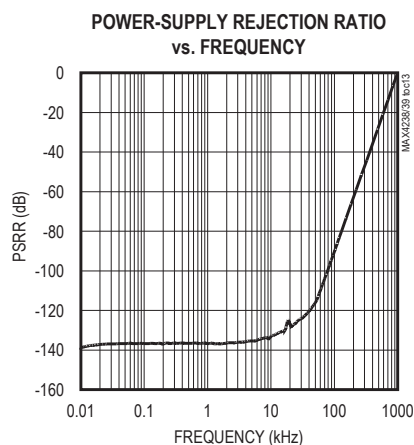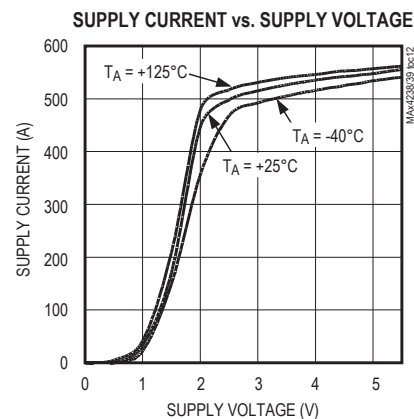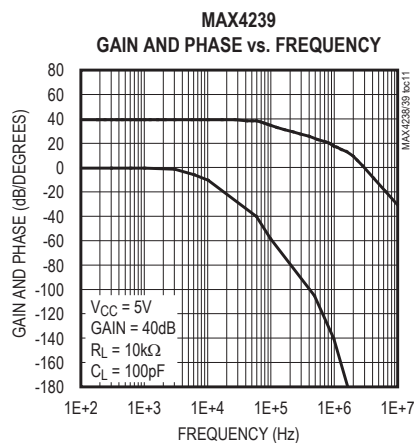**MAX4238 GAIN AND PHASE vs. FREQUENCY**

Typical Operating Characteristics (continued)

(V_{CC} = 5V, V_{CM} = 0V, R_L = 10kΩ connected to V_{CC}/2, $\overline{SHDN}$ = V_{CC}, T_A = +25°C, unless otherwise noted.)

MAX4239
GAIN AND PHASE vs. FREQUENCY

V_{CC} = 5V
GAIN = 40dB
R_L = 10kΩ
C_L = 0pF

MAX4239
GAIN AND PHASE vs. FREQUENCY

V_{CC} = 5V
GAIN = 40dB
R_L = 10kΩ
C_L = 100pF

SUPPLY CURRENT vs. SUPPLY VOLTAGE

T_A = +125°C
T_A = -40°C
T_A = +25°C

POWER-SUPPLY REJECTION RATIO
vs. FREQUENCY

COMMON-MODE REJECTION RATIO
vs. FREQUENCY

MAX4238
LARGE-SIGNAL TRANSIENT RESPONSE

IN
1V/div

OUT
1V/div

10s/div

A_V = 1V/V
R_L = 2kΩ
C_L = 100pF

MAX4238
SMALL-SIGNAL TRANSIENT RESPONSE

IN
50mV/div

OUT
50mV/div

10s/div

A_V = 1V/V
R_L = 2kΩ
C_L = 100pF

MAX4239
SMALL-SIGNAL TRANSIENT RESPONSE

IN
50mV/div

OUT
500mV/div

10s/div

A_V = 10V/V
R_L = 2kΩ
C_L = 100pF

OVERVOLTAGE RECOVERY TIME

IN
50mV/div

OUT
1V/div

400s/div

A_V = 100V/V
R_L = 10kΩ
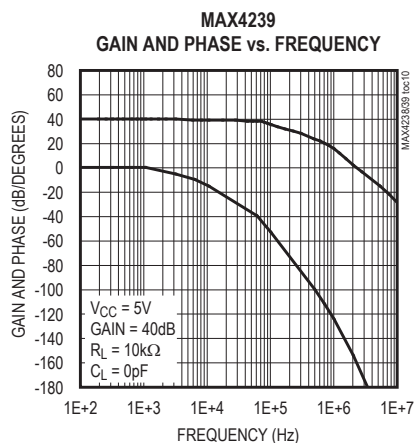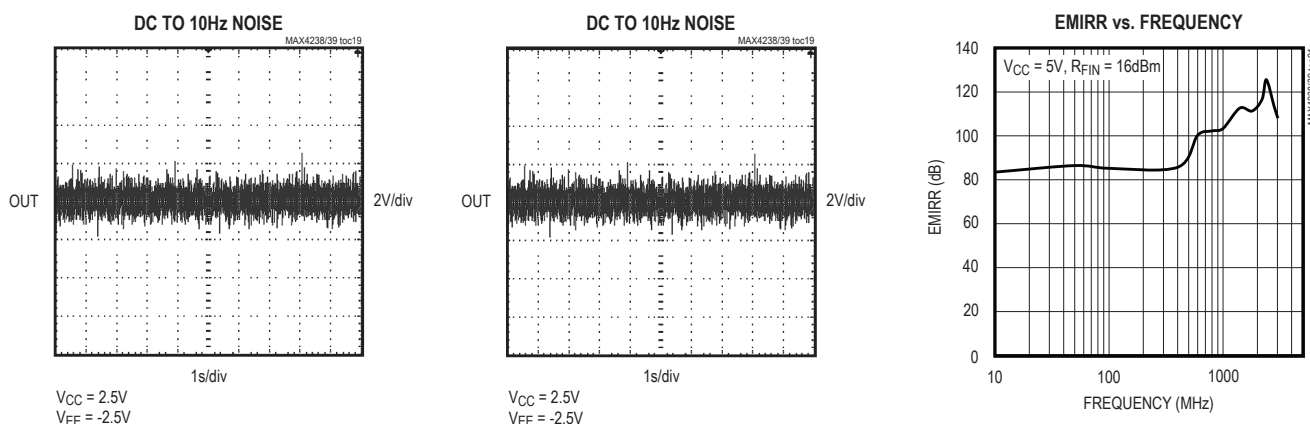V_{CC} = 2.5V
V_{EE} = -2.5V

Typical Operating Characteristics (continued)

(V_{CC} = 5V, V_{CM} = 0V, R_L = 10kΩ connected to V_{CC}/2, $\overline{SHDN}$ = V_{CC}, T_A = +25°C, unless otherwise noted.)

DC TO 10Hz NOISE

MAX4238/39 toc19

OUT

2V/div

1s/div

V_{CC} = 2.5V
V_{EE} = -2.5V

DC TO 10Hz NOISE

MAX4238/39 toc19

OUT

2V/div

1s/div

V_{CC} = 2.5V
V_{EE} = -2.5V

EMIRR vs. FREQUENCY

MAX4238/39 toc21

V_{CC} = 5V, R_{FIN} = 16dBm

EMIRR (dB)

FREQUENCY (MHz)

Pin Description

PIN			NAME	FUNCTION
TDFN	SOT23	SO		
1	1	6	OUT	Amplifier Output
2	2	4	GND	Ground
3	3	3	IN+	Noninverting Input
4	4	2	IN-	Inverting Input
5	5	1	$\overline{SHDN}$	Shutdown Input. Active-low shutdown, connect to V_{CC} for normal operation.
6	6	7	V_{CC}	Positive Power Supply
—	—	5, 8	N.C.	No Connection. Not internally connected.
—	—	—	EP	Exposed Pad (TDFN only). Connect EP to GND.

Detailed Description

The MAX4238/MAX4239 are high-precision amplifiers that have less than 2.5µV of input-referred offset and low 1/f noise. These characteristics are achieved through a patented autozeroing technique that samples and cancels the input offset and noise of the amplifier. The pseudorandom clock frequency varies from 10kHz to 15kHz, reducing intermodulation distortion present in chopper-stabilized amplifiers.

Offset Error Sources

To achieve very low offset, several sources of error common to autozero-type amplifiers need to be considered. The first contributor is the settling of the sampling capacitor. This type of error is independent of input-source impedance, or the size of the external gain-setting resistors. Maxim uses a patented design technique to avoid large changes in the voltage on the sampling capacitor to reduce settling time errors.

The second error contributor, which is present in both autozero and chopper-type amplifiers, is the charge injection from the switches. The charge injection appears as current spikes at the input, and combined with the impedance seen at the amplifier's input, contributes to input offset voltage. Minimize this feedthrough by reducing the size of the gain-setting resistors and the input-source impedance. A capacitor in parallel with the feedback resistor reduces the amount of clock feedthrough to the output by limiting the closed-loop bandwidth of the device.

The design of the MAX4238/MAX4239 minimizes the effects of settling and charge injection to allow specification of an input offset voltage of 0.1µV (typ) and less than 2.5µV over temperature (-40°C to +85°C).

1/f Noise

1/f noise, inherent in all semiconductor devices, is inversely proportional to frequency. 1/f noise increases 3dB/octave and dominates amplifier noise at lower frequencies. This noise appears as a constantly changing voltage in series with any signal being measured. The MAX4238/MAX4239 treat 1/f noise as a slow varying offset error, inherently canceling the 1/f noise.

Output Overload Recovery

Autozeroing amplifiers typically require a substantial amount of time to recover from an output overload. This is due to the time it takes for the null amplifier to correct the main amplifier to a valid output. The MAX4238/ MAX4239 require only 3.3ms to recover from an output overload (see *Electrical Characteristics* and *Typical Operating Characteristics*).

Shutdown

The MAX4238/MAX4239 feature a low-power (0.1µA) shutdown mode. When $\overline{SHDN}$ is pulled low, the clock stops and the device output enters a high-impedance state. Connect $\overline{SHDN}$ to V_{CC} for normal operation.

Applications Information

Minimum and Maximum Gain Configurations

The MAX4238 is a unity-gain stable amplifier with a gain-bandwidth product (GBWP) of 1MHz. The MAX4239 is decompensated for a GBWP of 6.5MHz and is stable with a gain of 10V/V. Unlike conventional operational amplifiers, the MAX4238/MAX4239 have a maximum gain specification. To maintain stability, set the gain of the MAX4238 between A_V = 1000V/V to 1V/V, and set the gain of the MAX4239 between A_V = 6700V/V and 10V/V.

ADC Buffer Amplifier

The low offset, fast settling time, and 1/f noise cancellation of the MAX4238/MAX4239 make these devices ideal for ADC buffers. The MAX4238/MAX4239 are well suited for low-speed, high-accuracy applications such as strain gauges (see *Typical Application Circuit*).

Error Budget Example

When using the MAX4238/MAX4239 as an ADC buffer, the temperature drift should be taken into account when determining the maximum input signal. With a typical offset drift of 10nV/°C, the drift over a 10°C range is 100nV. Setting this equal to 1/2LSB in a 16-bit system yields a full-scale range of 13mV. With a single 2.7V supply, an acceptable closed-loop gain is A_V = 200. This provides sufficient gain while maintaining headroom.

Pin Configurations
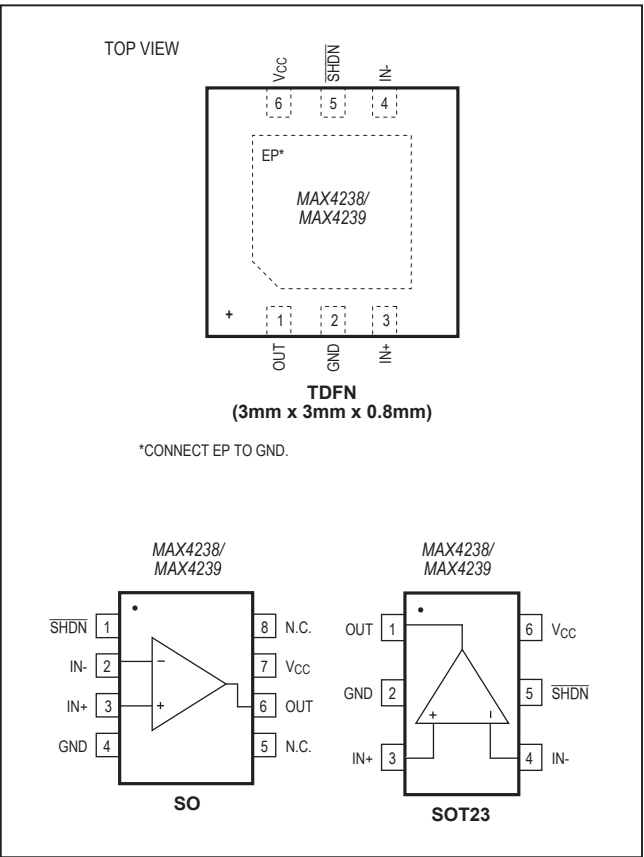
Chip Information

PROCESS: BiCMOS

Package Information

For the latest package outline information and land patterns (footprints), go to **www.maximintegrated.com/packages**. Note that a "+", "#", or "-" in the package code indicates RoHS status only. Package drawings may show a different suffix character, but the drawing pertains to the package regardles of RoHS status.

PACKAGE TYPE	PACKAGE CODE	OUTLINE NO.	LAND PATTERN NO.
6 SOT23	U6F-6	21-0058	90-0175
8 SO	S8-4	21-0041	90-0096
6 TDFN-EP	T633+2	21-0137	90-0058

Revision History

REVISION NUMBER	REVISION DATE	DESCRIPTION	PAGES CHANGED
2	5/06	—	—
3	8/11	Added MAX4238 and MAX4239 automotive-qualified parts	1
4	1/14	Updated the *Typical Operating Characteristics*	7
5	5/15	Added the *Benefits and Features* section	1

Mouser Electronics

Authorized Distributor

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  [MAX4239ASA-T](#) [MAX4239ASA](#)